January 2004

# FAIRCHILD SEMICONDUCTOR

# FDZ204P

# P-Channel 2.5V Specified PowerTrench<sup>®</sup> BGA MOSFET

#### **General Description**

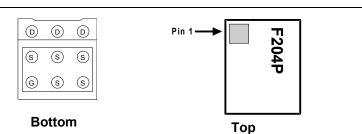
Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ204P minimizes both PCB space and  $R_{DS(ON)}$ . This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultralow profile packaging, low gate charge, and low  $R_{DS(ON)}$ .

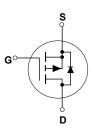
#### Applications

- Battery management
- Load switch
- Battery protection

#### Features

- -4.5 A, -20 V.  $R_{DS(ON)}$  = 45 m $\Omega$  @ V<sub>GS</sub> = -4.5 V  $R_{DS(ON)}$  = 75 m $\Omega$  @ V<sub>GS</sub> = -2.5 V
- Occupies only 4 mm<sup>2</sup> of PCB area. Less than 40% of the area of a SSOT-6
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Ultra-low Q<sub>g</sub> x R<sub>DS(ON)</sub> figure-of-merit.
- High power and current handling capability.





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

| Symbol                            | Parameter  |           | Ratings     | Units |
|-----------------------------------|--|-----------|-------------|-------|
| V <sub>DSS</sub>                  | Drain-Source Voltage                             |           | -20         | V     |
| V <sub>GSS</sub>                  | Gate-Source Voltage                              |           | ±12         | V     |
| ID                                | Drain Current – Continuous                       | (Note 1a) | -4.5        | A     |
|                                   | – Pulsed   |           | -20         |       |
| PD                                | Power Dissipation (Steady State)                 | (Note 1a) | 1.8         | W     |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range |           | -55 to +150 | °C    |

### **Thermal Characteristics**

| R <sub>0JA</sub> | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 67 | °C/W |
|------------------|---|-----------|----|------|
| R <sub>0JB</sub> | Thermal Resistance, Junction-to-Ball    | (Note 1)  | 11 | °C/W |
| $R_{\theta JC}$  | Thermal Resistance, Junction-to-Case    | (Note 1)  | 1  | °C/W |

# Package Marking and Ordering Information

| Device Marking | Device  | Reel Size | Tape width | Quantity   |
|----------------|---------|-----------|------------|------------|
| 204P           | FDZ204P | 7"        | 8mm        | 3000 units |

|  | ectrical Characteristics T <sub>A</sub> = 25°C unless otherwise noted |   |      |       |      |       |  |
|--|---|---|------|-------|------|-------|--|
| Symbol                                 | Parameter   | Test Conditions   | Min  | Тур   | Max  | Units |  |
| Off Char                               | acteristics   |   |      |       |      |       |  |
| BV <sub>DSS</sub>                      | Drain–Source Breakdown Voltage  | $V_{GS} = 0 V, I_{D} = -250 \mu A$  | -20  |       |      | V     |  |
| <u>ΔBVdss</u><br>ΔTj                   | Breakdown Voltage Temperature<br>Coefficient                          | $I_D$ = –250 µA, Referenced to 25°C   |      | -17   |      | mV/°C |  |
| I <sub>DSS</sub>                       | Zero Gate Voltage Drain Current                                       | $V_{DS} = -16 V$ , $V_{GS} = 0 V$   |      |       | -1   | μΑ    |  |
| I <sub>GSSF</sub>                      | Gate–Body Leakage, Forward  | $V_{GS} = -12 V$ , $V_{DS} = 0 V$   |      |       | -100 | nA    |  |
| I <sub>GSSR</sub>                      | Gate–Body Leakage, Reverse  | $V_{GS} = 12 V$ , $V_{DS} = 0 V$  |      |       | 100  | nA    |  |
| On Char                                | acteristics (Note 2)  |   |      |       |      |       |  |
| V <sub>GS(th)</sub>                    | Gate Threshold Voltage  | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$   | -0.6 | -0.9  | -1.5 | V     |  |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage<br>Temperature Coefficient                     | $I_D$ = –250 µA, Referenced to 25°C   |      | 3     |      | mV/°C |  |
| R <sub>DS(on)</sub>                    | Static Drain–Source   | $V_{GS} = -4.5 \text{ V},  I_D = -4.5 \text{ A}$  |      | 37    | 45   | mΩ    |  |
|  | On–Resistance   | $V_{GS} = -2.5 V$ , $I_D = -3.5 A$  |      | 57    | 75   |       |  |
|  |   | $V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -4.5 \text{ A}, \text{T}_{J} = 125^{\circ}\text{C}$ |      | 50    | 65   |       |  |
| <b>g</b> <sub>FS</sub>                 | Forward Transconductance  | $V_{DS} = -5 V$ , $I_{D} = -4.5 A$  |      | 15    |      | S     |  |
| Dynamic                                | Characteristics   |   |      |       | ÷    | ÷     |  |
| Ciss                                   | Input Capacitance   | $V_{DS} = -10 \text{ V},  V_{GS} = 0 \text{ V},$  |      | 884   |      | pF    |  |
| Coss                                   | Output Capacitance  | f = 1.0 MHz   |      | 258   |      | pF    |  |
| C <sub>rss</sub>                       | Reverse Transfer Capacitance  |   |      | 103   |      | pF    |  |
| Switchin                               | g Characteristics (Note 2)  |   |      |       |      |       |  |
| t <sub>d(on)</sub>                     | Turn–On Delay Time  | $V_{DD} = -6 V$ , $I_D = -1 A$ ,  |      | 12    | 22   | ns    |  |
| tr                                     | Turn–On Rise Time   | $V_{GS}$ = -4.5 V, $R_{GEN}$ = 6 $\Omega$   |      | 9     | 18   | ns    |  |
| t <sub>d(off)</sub>                    | Turn–Off Delay Time   |   |      | 36    | 58   | ns    |  |
| t <sub>f</sub>                         | Turn–Off Fall Time  |   |      | 24    | 38   | ns    |  |
| Qg                                     | Total Gate Charge   | $V_{DS} = -10 V$ , $I_D = -4.5 A$ ,   |      | 9     | 13   | nC    |  |
| $Q_{gs}$                               | Gate–Source Charge  | $V_{GS} = -4.5 V$   |      | 2     |      | nC    |  |
| Q <sub>gd</sub>                        | Gate–Drain Charge   |   |      | 3     |      | nC    |  |
| Drain-S                                | ource Diode Characteristics   | and Maximum Ratings   |      |       |      |       |  |
| ls                                     | Maximum Continuous Drain-Sourc  | e Diode Forward Current   |      |       | -1.5 | А     |  |
| V <sub>SD</sub>                        | Drain–Source Diode Forward<br>Voltage                                 | $V_{GS} = 0 V$ , $I_S = -1.5 A$ (Note 2)  |      | -0.76 | -1.2 | V     |  |
| t <sub>rr</sub>                        | Diode Reverse Recovery Time   | I <sub>F</sub> = -5.5 A,  |      | 25    |      | nS    |  |
| Q <sub>rr</sub>                        | Diode Reverse Recovery Charge   | $d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$  |      | 26    |      | nC    |  |

Notes:

R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R<sub>0JB</sub>, is defined for reference. For R<sub>0JC</sub>, the thermal reference point for the case is defined as the top surface of the copper chip carrier. R<sub>0JC</sub> and R<sub>0JB</sub> are guaranteed by design while R<sub>0JA</sub> is determined by the user's board design.



 $Scale 1: 1 \mbox{ on letter size paper} \\ 2. 2. \qquad \mbox{Pulse Test: Pulse Width < } 300 \mu s, \mbox{Duty Cycle < } 2.0\%$ 

67 °C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB

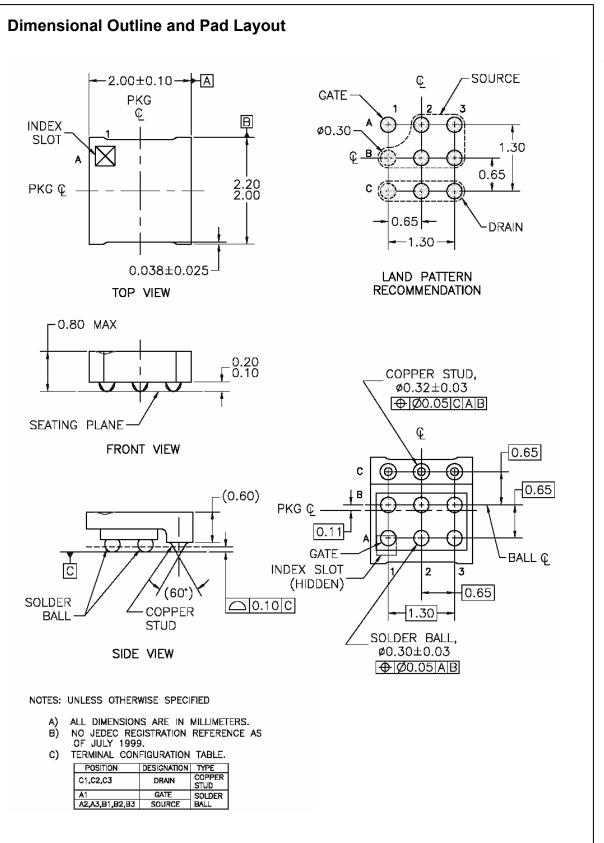
a)

b) 00000

155 °C/W when mounted on a minimum pad of 2 oz copper

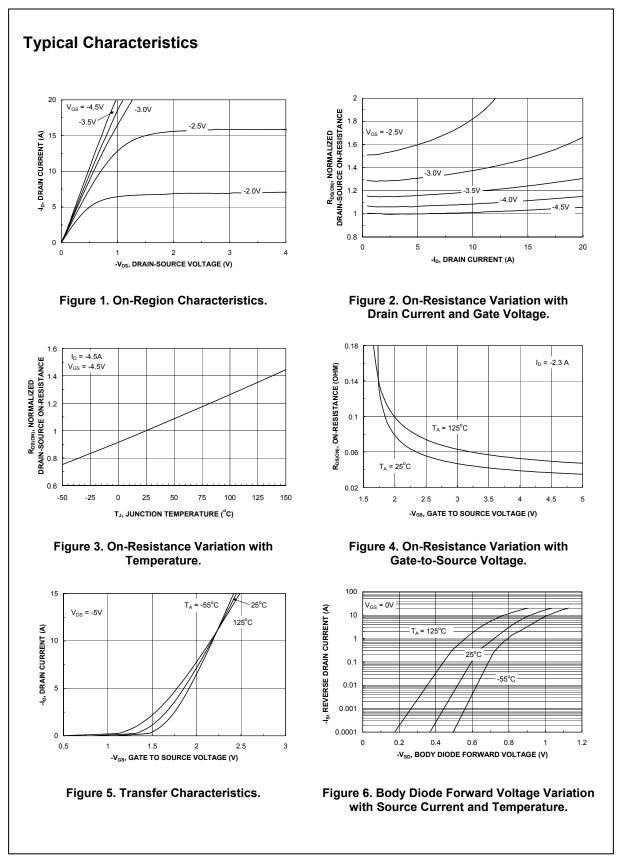
FDZ204P Rev. D4 (W)

FDZ204P

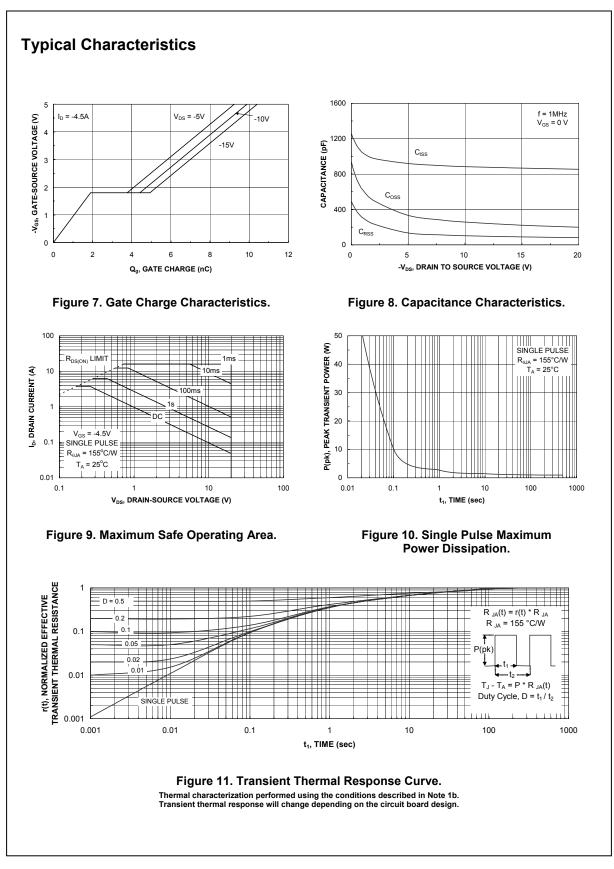


# FDZ204P

FDZ204P Rev. D4 (W)



FDZ204P



FDZ204P

FDZ204P Rev. D4 (W)

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|---|--|---|---|
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